

TOSHIBA GTR Module Silicon N Channel IGBT

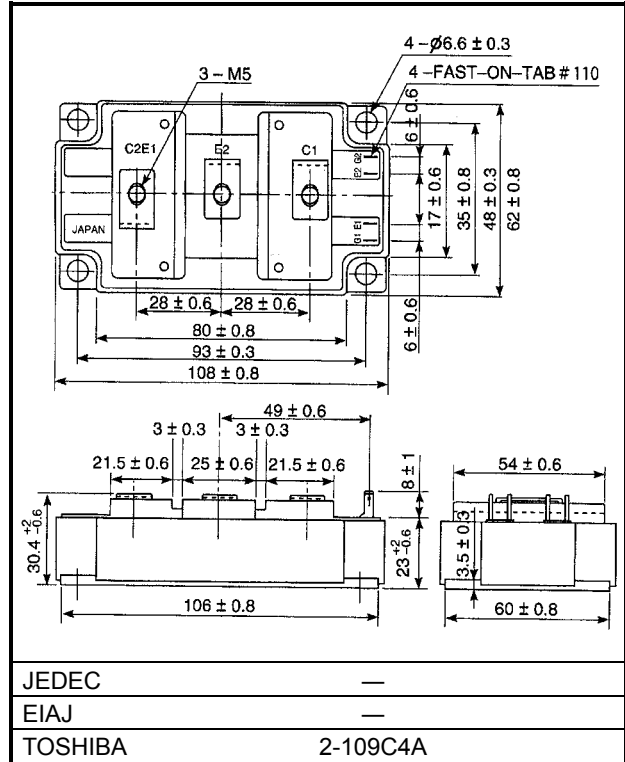
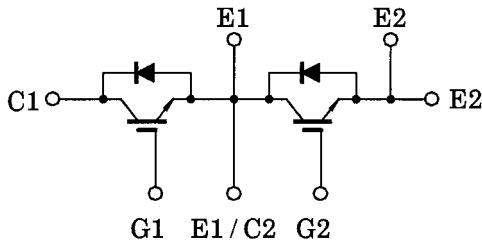
## MG150Q2YS51

High Power Switching Applications  
 Motor Control Applications

Unit: mm

- High input impedance
- High speed :  $t_f = 0.3\mu s$  (Max)  
 @Inductive Load
- Low saturation voltage  
 :  $V_{CE(sat)} = 3.6V$  (Max)
- Enhancement-mode
- Includes a complete half bridge in one package.
- The electrodes are isolated from case.

### Equivalent Circuit



### Maximum Ratings ( $T_a = 25^\circ C$ )

Weight: 430g

Characteristic	Symbol	Rating	Unit
Collector-emitter voltage	$V_{CES}$	1200	V
Gate-emitter voltage	$V_{GES}$	$\pm 20$	V
Collector current	DC	$I_C$ ( $25^\circ C / 80^\circ C$ )	200 / 150
	1ms	$I_{CP}$ ( $25^\circ C / 80^\circ C$ )	400 / 300
Forward current	DC	$I_F$	150
	1ms	$I_{FM}$	300
Collector power dissipation ( $T_c = 25^\circ C$ )	$P_C$	1250	W
Junction temperature	$T_j$	150	$^\circ C$
Storage temperature range	$T_{stg}$	-40 ~ 125	$^\circ C$
Isolation voltage	$V_{Isol}$	2500 (AC 1 min.)	V
Screw torque (Terminal / mounting)	—	3 / 3	N·m

## Electrical Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Condition	Min	Typ.	Max	Unit	
Gate leakage current		$I_{GES}$	$V_{GE} = \pm 20V, V_{CE} = 0$	—	—	$\pm 500$	nA	
Collector cut-off current		$I_{CES}$	$V_{CE} = 1200V, V_{GE} = 0$	—	—	2.0	mA	
Gate-emitter cut-off voltage		$V_{GE (off)}$	$I_C = 150mA, V_{CE} = 5V$	3.0	—	6.0	V	
Collector-emitter saturation voltage		$V_{CE (sat)}$	$I_C = 150A, V_{GE} = 15V$	$T_j = 25^\circ C$	—	2.8	3.6	V
				$T_j = 125^\circ C$	—	3.1	4.0	
Input capacitance		$C_{ies}$	$V_{CE} = 10V, V_{GE} = 0, f = 1MHz$	—	18.0	—	nF	
Switching time	Turn-on delay time	$t_{d(on)}$	Inductive load $V_{CC} = 600V$ $I_C = 150A$ $V_{GE} = \pm 15V$ $R_G = 5.6\Omega$  (Note 1)	—	0.05	—	$\mu s$	
	Rise time	$t_r$		—	0.05	—		
	Turn-on time	$t_{on}$		—	0.2	—		
	Turn-off delay time	$t_{d(off)}$		—	0.5	—		
	Fall time	$t_f$		—	0.1	0.3		
	Turn-off time	$t_{off}$		—	0.6	—		
Forward voltage		$V_F$	$I_F = 150A, V_{GE} = 0$	—	2.4	3.5	V	
Reverse recovery time		$t_{rr}$	$I_F = 150A, V_{GE} = -10V$ $di/dt = 700A/\mu s$ (Note 1)	—	0.1	0.25	$\mu s$	
Thermal resistance		$R_{th (j-c)}$	Transistor stage	—	—	0.1	$^\circ C/W$	
			Diode stage	—	—	0.24		

Note 1: Switching time and reverse recovery time test circuit & timing chart

